

# PHK12NQ10T

N-channel TrenchMOS standard level FET

Rev. 02 — 24 November 2009

Product data sheet

## 1. Product profile

### 1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

### 1.2 Features and benefits

- Low conduction losses due to low on-state resistance

### 1.3 Applications

- DC-to-DC primary side switching
- Portable equipment

### 1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \geq 25^\circ\text{C}; T_j \leq 150^\circ\text{C}$	-	-	100	V
$I_D$	drain current	$T_{sp} = 25^\circ\text{C}; V_{GS} = 10\text{ V};$ see <a href="#">Figure 3</a> and <a href="#">1</a>	-	-	11.6	A
$P_{tot}$	total power dissipation	$T_{sp} = 25^\circ\text{C};$ see <a href="#">Figure 2</a>	-	-	8.9	W
<b>Dynamic characteristics</b>						
$Q_{GD}$	gate-drain charge	$V_{GS} = 10\text{ V}; I_D = 12\text{ A};$ $V_{DS} = 50\text{ V}; T_j = 25^\circ\text{C};$ see <a href="#">Figure 11</a>	-	9	-	nC
<b>Static characteristics</b>						
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = 10\text{ V}; I_D = 6\text{ A};$ $T_j = 25^\circ\text{C};$ see <a href="#">Figure 9</a> and <a href="#">10</a>	-	23.7	28	mΩ

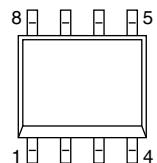


founded by Philips

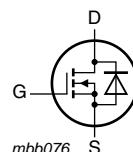
## 2. Pinning information

**Table 2. Pinning information**

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		
2	S	source		
3	S	source		
4	G	gate		
5	D	drain		
6	D	drain		
7	D	drain		
8	D	drain		



**SOT96-1 (SO8)**



## 3. Ordering information

**Table 3. Ordering information**

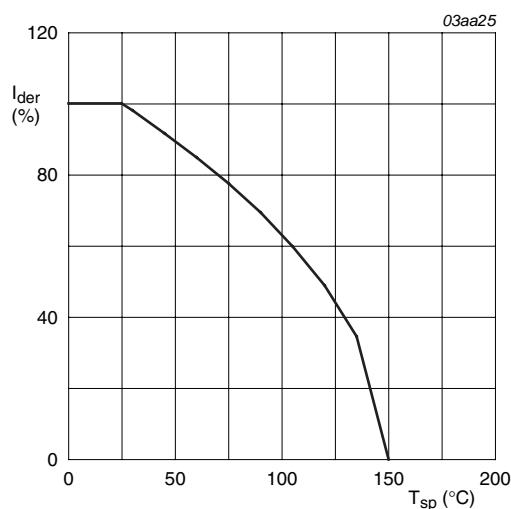
Type number	Package			Version
	Name	Description	Version	
PHK12NQ10T	SO8	plastic small outline package; 8 leads; body width 3.9 mm		SOT96-1

## 4. Limiting values

**Table 4. Limiting values**

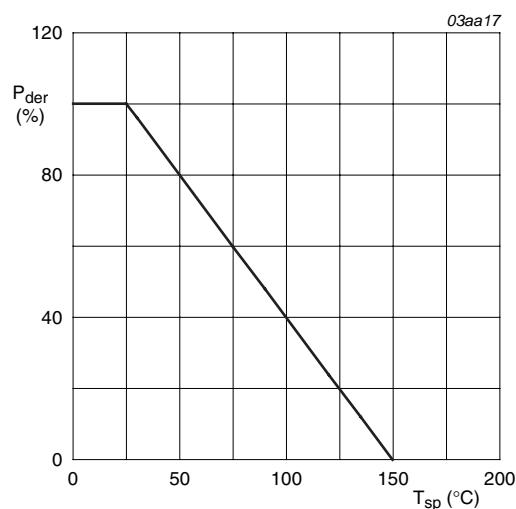
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \geq 25^\circ\text{C}; T_j \leq 150^\circ\text{C}$	-	100	V
$V_{DGR}$	drain-gate voltage	$T_j \geq 25^\circ\text{C}; T_j \leq 150^\circ\text{C}; R_{GS} = 20\text{ k}\Omega$	-	100	V
$V_{GS}$	gate-source voltage		-20	20	V
$I_D$	drain current	$T_{sp} = 100^\circ\text{C}; V_{GS} = 10\text{ V}$ ; see <a href="#">Figure 1</a>	-	7.4	A
		$T_{sp} = 25^\circ\text{C}; V_{GS} = 10\text{ V}$ ; see <a href="#">Figure 3</a> and <a href="#">1</a>	-	11.6	A
$I_{DM}$	peak drain current	$T_{sp} = 25^\circ\text{C}; t_p \leq 10\text{ }\mu\text{s}$ ; pulsed; see <a href="#">Figure 3</a>	-	48	A
$P_{tot}$	total power dissipation	$T_{sp} = 25^\circ\text{C}$ ; see <a href="#">Figure 2</a>	-	8.9	W
$T_{stg}$	storage temperature		-55	150	°C
$T_j$	junction temperature		-55	150	°C
<b>Source-drain diode</b>					
$I_S$	source current	$T_{sp} = 25^\circ\text{C}$	-	12	A
$I_{SM}$	peak source current	$T_{sp} = 25^\circ\text{C}; t_p \leq 10\text{ }\mu\text{s}$ ; pulsed	-	48	A
<b>Avalanche ruggedness</b>					
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	$V_{GS} = 10\text{ V}; T_{j(init)} = 25^\circ\text{C}; I_D = 11.5\text{ A}; V_{sup} \leq 100\text{ V}$ ; unclamped; $t_p = 0.1\text{ ms}$	-	65	mJ



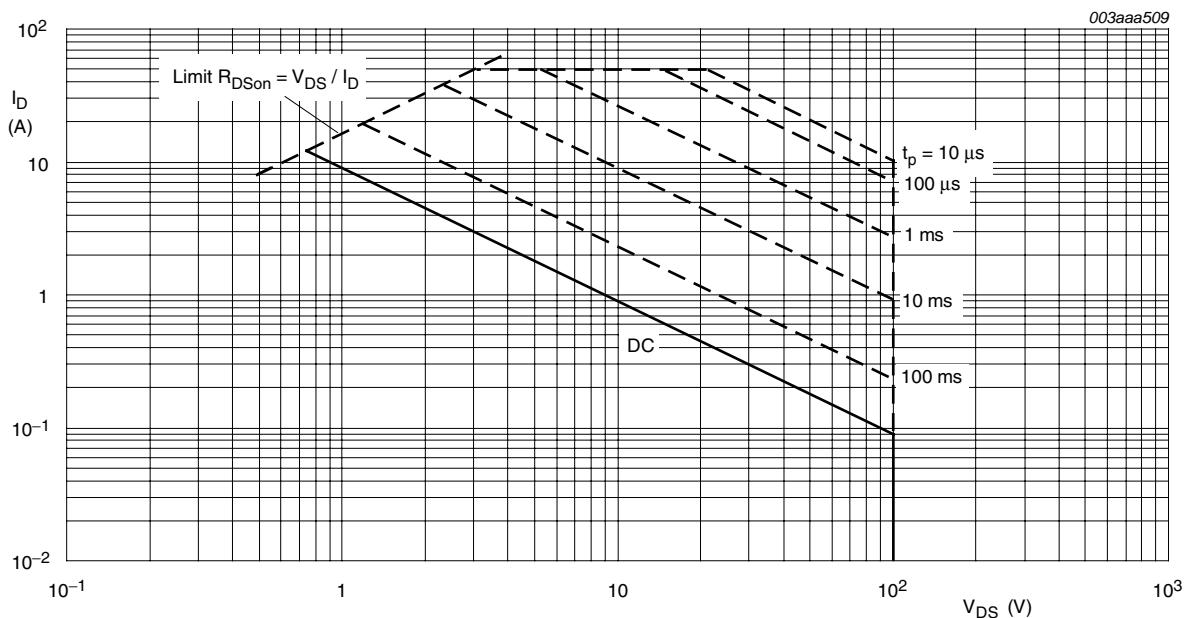
$$I_{der} = \frac{I_D}{I_{D(25^\circ C)}} \times 100\%$$

**Fig 1.** Normalized continuous drain current as a function of solder point temperature



$$P_{der} = \frac{P_{tot}}{P_{tot(25^\circ C)}} \times 100\%$$

**Fig 2.** Normalized total power dissipation as a function of solder point temperature



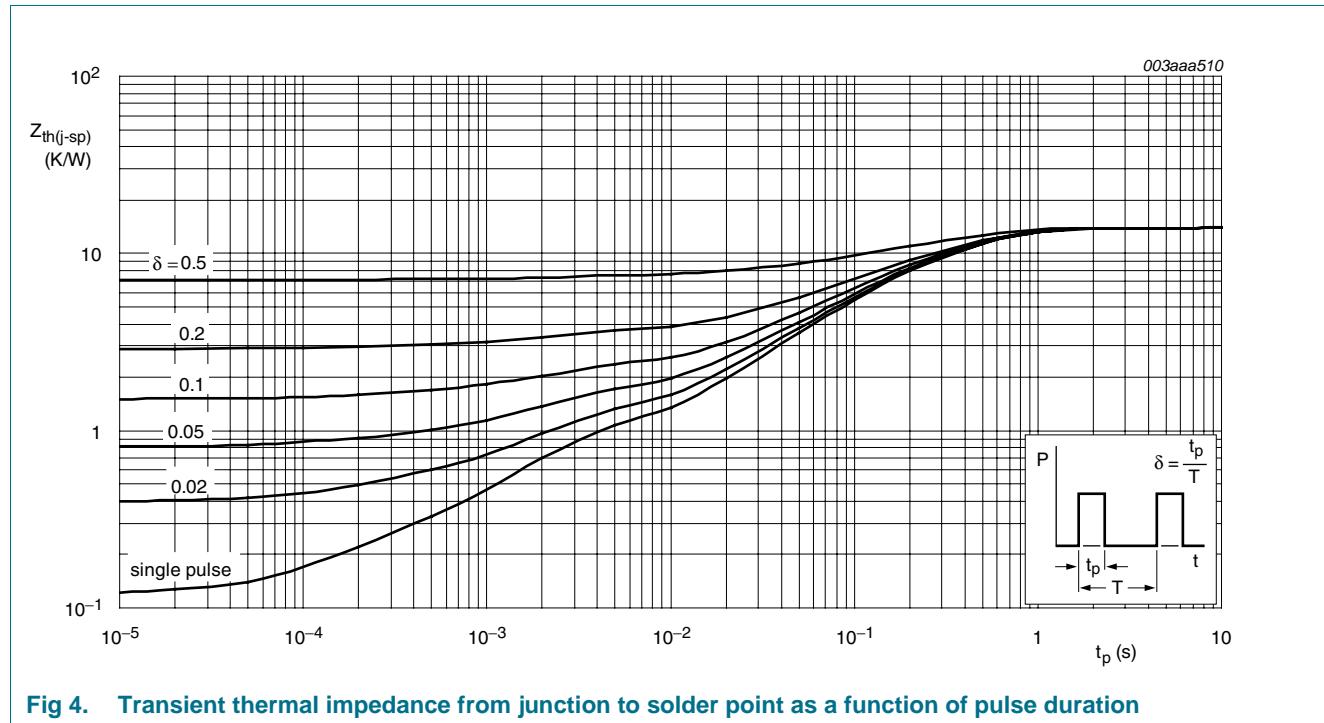
$T_{sp} = 25^\circ C$ ;  $I_{DM}$  is single pulse;

**Fig 3.** Safe operating area; continuous and peak drain currents as a function of drain-source voltage

## 5. Thermal characteristics

**Table 5. Thermal characteristics**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	see <a href="#">Figure 4</a>	-	-	15	K/W

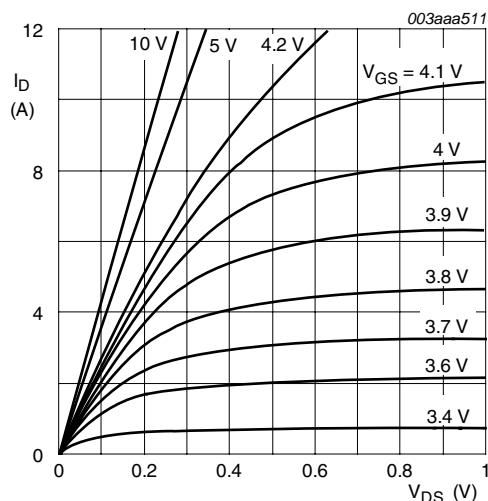


**Fig 4. Transient thermal impedance from junction to solder point as a function of pulse duration**

## 6. Characteristics

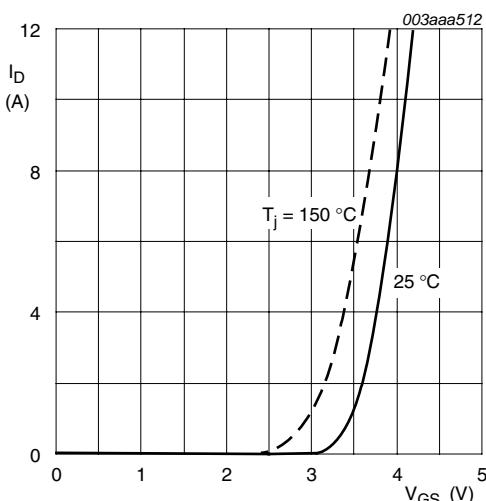
**Table 6. Characteristics**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static characteristics</b>						
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	I <sub>D</sub> = 250 µA; V <sub>GS</sub> = 0 V; T <sub>j</sub> = -55 °C	89	-	-	V
		I <sub>D</sub> = 250 µA; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C	100	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	I <sub>D</sub> = 1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = 150 °C; see <a href="#">Figure 8</a>	1.2	-	-	V
		I <sub>D</sub> = 1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = -55 °C; see <a href="#">Figure 8</a>	-	-	4.4	V
		I <sub>D</sub> = 1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = 25 °C; see <a href="#">Figure 8</a>	2	3	4	V
I <sub>DSS</sub>	drain leakage current	V <sub>DS</sub> = 100 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	-	1	µA
		V <sub>DS</sub> = 100 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 150 °C	-	-	100	µA
I <sub>GSS</sub>	gate leakage current	V <sub>GS</sub> = 20 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	10	100	nA
		V <sub>GS</sub> = -20 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	10	100	nA
R <sub>DSon</sub>	drain-source on-state resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 6 A; T <sub>j</sub> = 150 °C; see <a href="#">Figure 9</a> and <a href="#">10</a>	-	52.1	61.6	mΩ
		V <sub>GS</sub> = 10 V; I <sub>D</sub> = 6 A; T <sub>j</sub> = 25 °C; see <a href="#">Figure 9</a> and <a href="#">10</a>	-	23.7	28	mΩ
<b>Dynamic characteristics</b>						
Q <sub>G(tot)</sub>	total gate charge	I <sub>D</sub> = 12 A; V <sub>DS</sub> = 50 V; V <sub>GS</sub> = 10 V; T <sub>j</sub> = 25 °C; see <a href="#">Figure 11</a>	-	35	-	nC
Q <sub>GS</sub>	gate-source charge		-	7.8	-	nC
Q <sub>GD</sub>	gate-drain charge		-	9	-	nC
C <sub>iss</sub>	input capacitance	V <sub>DS</sub> = 25 V; V <sub>GS</sub> = 0 V; f = 1 MHz; T <sub>j</sub> = 25 °C; see <a href="#">Figure 12</a>	-	1965	-	pF
C <sub>oss</sub>	output capacitance	V <sub>DS</sub> = 25 V; V <sub>GS</sub> = 0 V; f = 1 MHz; T <sub>j</sub> = 25 °C; see <a href="#">Figure 11</a>	-	260	-	pF
C <sub>rss</sub>	reverse transfer capacitance	V <sub>DS</sub> = 25 V; V <sub>GS</sub> = 0 V; f = 1 MHz; T <sub>j</sub> = 25 °C; see <a href="#">Figure 12</a>	-	90	-	pF
t <sub>d(on)</sub>	turn-on delay time	V <sub>DS</sub> = 50 V; R <sub>L</sub> = 8.3 Ω; V <sub>GS</sub> = 10 V; R <sub>G(ext)</sub> = 6 Ω; T <sub>j</sub> = 25 °C; I <sub>D</sub> = 6 A	-	23	-	ns
t <sub>r</sub>	rise time		-	21	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	52	-	ns
t <sub>f</sub>	fall time		-	11	-	ns
<b>Source-drain diode</b>						
V <sub>SD</sub>	source-drain voltage	I <sub>S</sub> = 12 A; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C; see <a href="#">Figure 13</a>	-	0.83	1	V
t <sub>rr</sub>	reverse recovery time	I <sub>S</sub> = 12 A; dI <sub>S</sub> /dt = -100 A/µs; V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 25 V; T <sub>j</sub> = 25 °C	-	86	-	ns
Q <sub>r</sub>	recovered charge	I <sub>S</sub> = 12 A; dI <sub>S</sub> /dt = -100 A/µs; V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 25 V; T <sub>j</sub> = 25 °C	-	120	-	nC



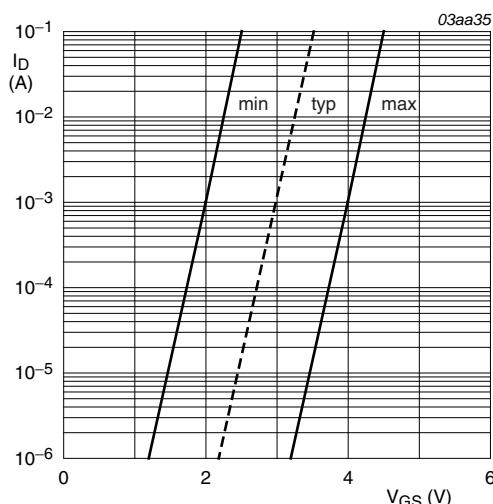
$T_j = 25^\circ\text{C}$

**Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values**



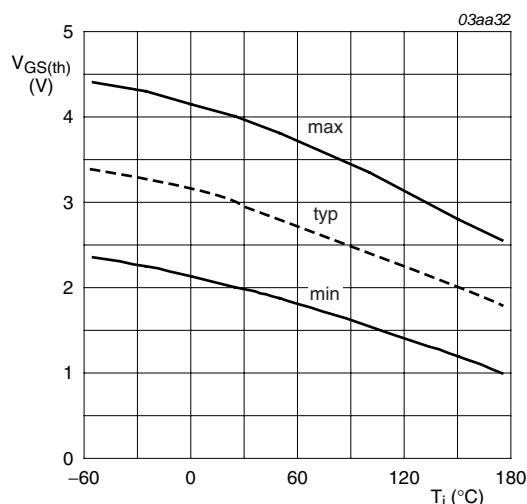
$T_j = 25^\circ\text{C}$  and  $150^\circ\text{C}$ ;  $V_{DS} > I_D \times R_{DSon}$

**Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values**



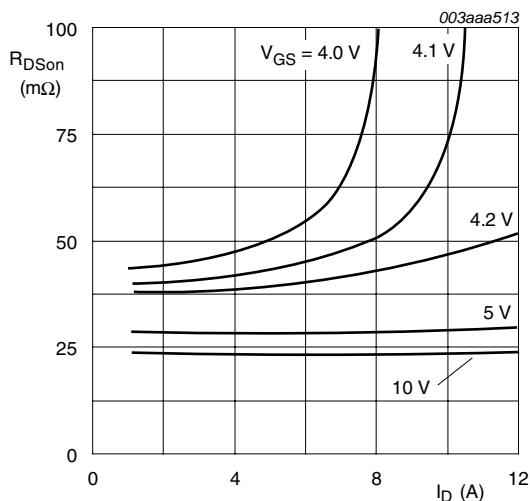
$T_j = 25^\circ\text{C}; V_{DS} = 5\text{V}$

**Fig 7. Sub-threshold drain current as a function of gate-source voltage**

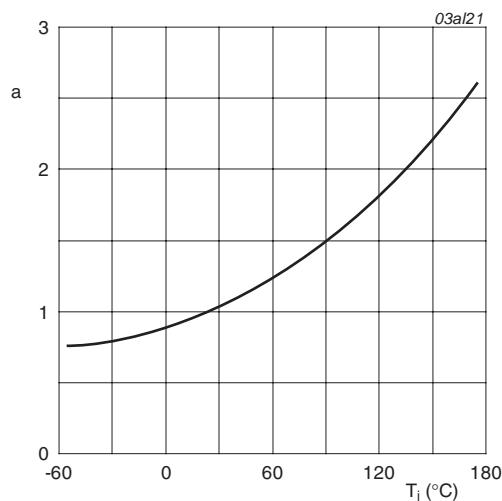


$I_D = 1\text{mA}; V_{DS} = V_{GS}$

**Fig 8. Gate-source threshold voltage as a function of junction temperature**

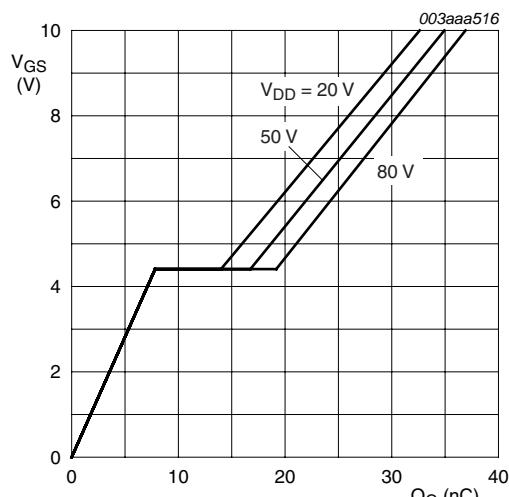

 $T_j = 25^\circ C$ 

**Fig 9.** Drain-source on-state resistance as a function of drain current; typical values

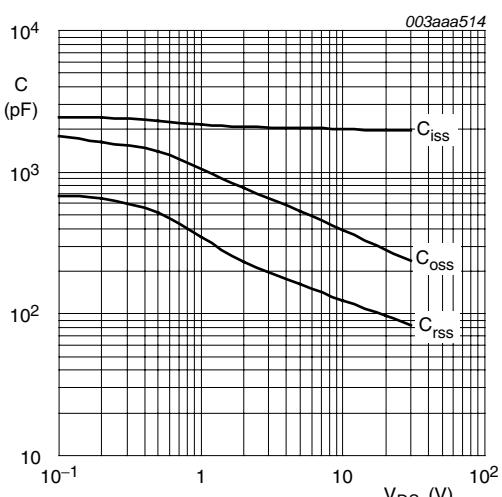


$$a = \frac{R_{DSon}}{R_{DSon}(25^\circ C)}$$

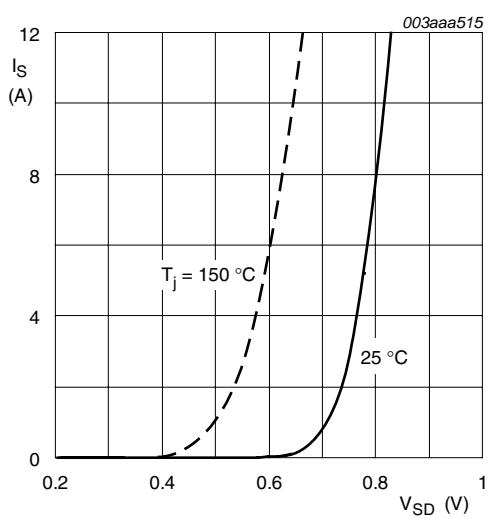
**Fig 10.** Normalized drain-source on-state resistance factor as a function of junction temperature


 $I_D = 12A; V_{DD} = 20V, 50V \text{ and } 80V$ 

**Fig 11.** Gate-source voltage as a function of gate charge; typical values


 $V_{GS} = 0V; f = 1MHz$ 

**Fig 12.** Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



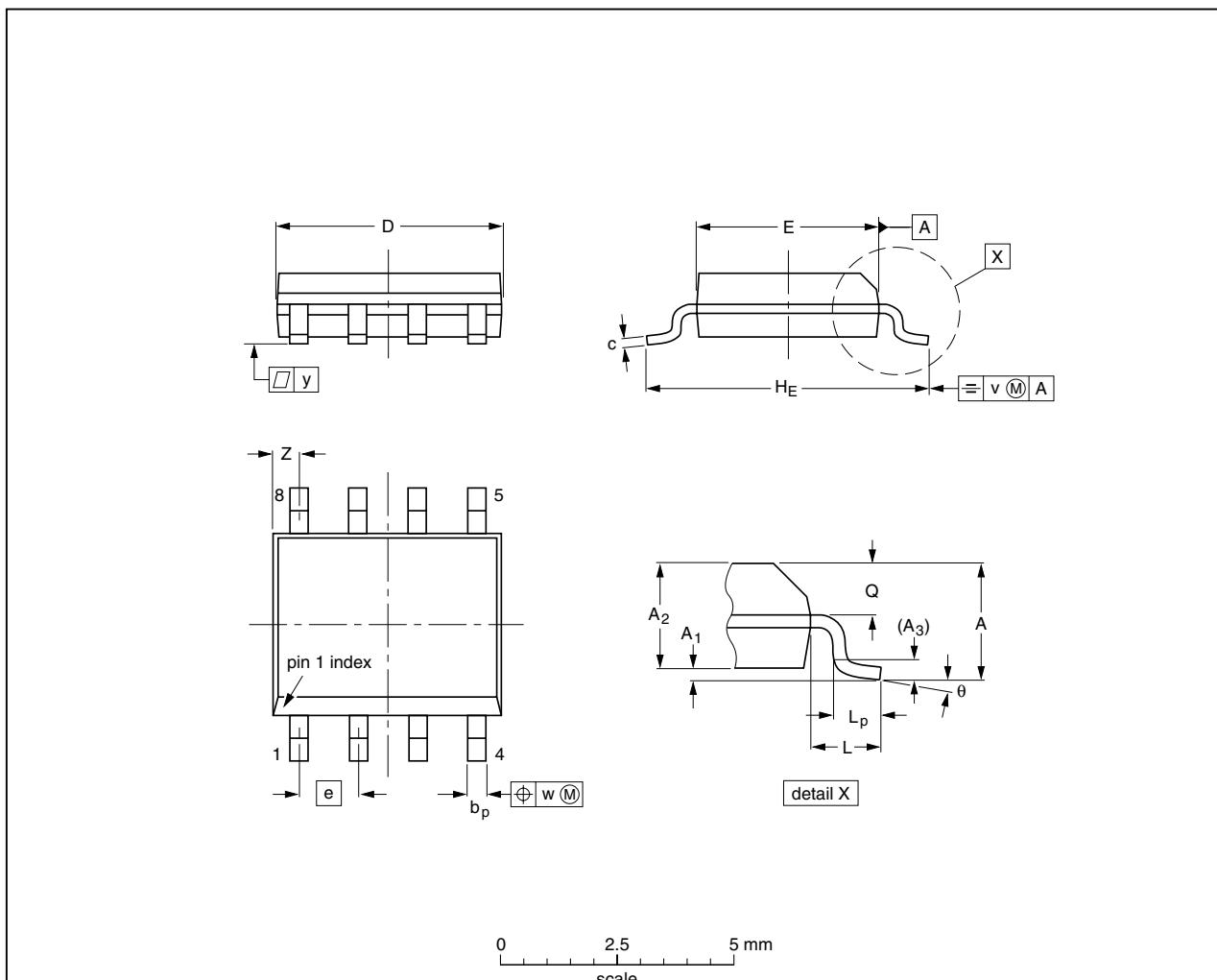
$T_j = 25^\circ\text{C}$  and  $150^\circ\text{C}; V_{GS} = 0\text{V}$

**Fig 13. Source current as a function of source-drain voltage; typical values**

## 7. Package outline

SO8: plastic small outline package; 8 leads; body width 3.9 mm

SOT96-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	b <sub>p</sub>	c	D <sup>(1)</sup>	E <sup>(2)</sup>	e	H <sub>E</sub>	L	L <sub>p</sub>	Q	v	w	y	z <sup>(1)</sup>	θ
mm	1.75 0.10	0.25 1.25	1.45 0.25	0.25	0.49 0.36	0.25 0.19	5.0 4.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8° 0°
inches	0.069 0.004	0.010 0.049	0.057 0.049	0.01	0.019 0.014	0.0100 0.0075	0.20 0.19	0.16 0.15	0.05	0.244 0.228	0.041	0.039 0.016	0.028 0.024	0.01	0.01	0.004	0.028 0.012	

### Notes

- Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.
- Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT96-1	076E03	MS-012				99-12-27 03-02-18

Fig 14. Package outline SOT96-1 (SO8)

## 8. Revision history

**Table 7. Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes
PHK12NQ10T_2	20091124	Product data sheet	-	PHK12NQ10T-01
Modifications:	<ul style="list-style-type: none"><li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li><li>Legal texts have been adapted to the new company name where appropriate.</li></ul>			
PHK12NQ10T-01 (9397 750 11949)	20030915	Product data	-	-

## 9. Legal information

### 9.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

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## 11. Contents

<b>1</b>	<b>Product profile</b>	<b>1</b>
1.1	General description	1
1.2	Features and benefits	1
1.3	Applications	1
1.4	Quick reference data	1
<b>2</b>	<b>Pinning information</b>	<b>2</b>
<b>3</b>	<b>Ordering information</b>	<b>2</b>
<b>4</b>	<b>Limiting values</b>	<b>2</b>
<b>5</b>	<b>Thermal characteristics</b>	<b>4</b>
<b>6</b>	<b>Characteristics</b>	<b>5</b>
<b>7</b>	<b>Package outline</b>	<b>9</b>
<b>8</b>	<b>Revision history</b>	<b>10</b>
<b>9</b>	<b>Legal information</b>	<b>11</b>
9.1	Data sheet status	11
9.2	Definitions	11
9.3	Disclaimers	11
9.4	Trademarks	11
<b>10</b>	<b>Contact information</b>	<b>11</b>

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